## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10718256	CRANINCKX, JAN FRANS LUCIEN
Examiner	Art Unit
Kumar, Pankaj	2611

SEARCHED								
Class	Subclass	Date	Examiner					
375	354;371,373,374,375,376,316,322,324,327,294,293,286	7/4/2007	PK					
329	304,306,307	7/4/2007	PK					
332	117,123,126,127	7/4/2007	PK					
342	73,89,98,100,102,103	7/4/2007	PK					

	SEARCH NOT	ES	-
	Search Notes	Date	Examiner
EAST		7/4/2007.	PK
IEEE		7/4/2007	PK

INTERFERENCE SEARCH							
Class		Subclass	Date	Examiner			
375	294		7/4/2007	PK			